

Description

The HXY302DF uses advanced trench technology to provide excellent $R_{\text{DS(ON)}}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.

General Features

 $V_{DS} = 30V I_{D} = 30A$

 $R_{DS(ON)}$ < 12m Ω @ V_{GS} =10V

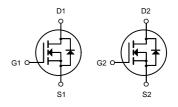
Application

Lithium battery protection

Wireless impact

Mobile phone fast charging





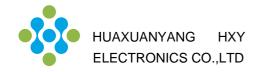
Dual N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
HXY302DF	DFN3X3-8L	302 XXX YYYY	5000

Absolute Maximum Ratings (T_C=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain-Source Voltage	30	V
VGS	Gate-Source Voltage	±20	V
I ⊳@T c=25°C	Continuous Drain Current, V _{GS} @ 10V ¹	30	Α
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ 10V ¹	18	А
IDM	Pulsed Drain Current ²	50	Α
EAS	Single Pulse Avalanche Energy ³	24.2	mJ
IAS	Avalanche Current	22	Α
P _D @T _A =25℃	Total Power Dissipation ⁴	1.5	W
TSTG	Storage Temperature Range	-55 to 150	$^{\circ}$ C
TJ	Operating Junction Temperature Range	-55 to 150	$^{\circ}$
R _θ JA	Thermal Resistance Junction-Ambient ¹	85	°C/W
R₀JC	Thermal Resistance Junction-Case ¹	25	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			٧	
△BV _{DSS} /△T _J	BVDSS Temperature Coefficient	Reference to 25°C,I _D =1mA		0.023		V/°C	
D	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =8A	V _{GS} =10V , I _D =8A		10	12	0
R _{DS(ON)}	Static Dialii-Source On-Resistance	V _{GS} =4.5V , I _D =6A		15	18	mΩ	
V _{GS(th)}	Gate Threshold Voltage	\/\/	1.2		2.5	V	
△V _{GS(th)}	V _{GS(th)} Temperature Coefficient	──V _{GS} =V _{DS} , I _D =250uA		-5.08		mV/°C	
1	Drain Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1		
IDSS	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , T _J =55°C			5	uA	
Igss	Gate-Source Leakage Current	V _{GS} = ±20V , V _{DS} =0V			±100	nA	
gfs	Forward Transconductance	V _{DS} =5V , I _D =8A		24		S	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.8		Ω	
Qg	Total Gate Charge (4.5V)			9.63			
Q _{gs}	Gate-Source Charge	V _{DS} =15V , V _{GS} =4.5V , I _D =8A		3.88		nC	
Q _{gd}	Gate-Drain Charge			3.44			
T _{d(on)}	Turn-On Delay Time	V_{DD} =15V , V_{GS} =10V , R_{G} =1.5 Ω		4.2			
Tr	Rise Time			8.2		no	
T _{d(off)}	Turn-Off Delay Time			31		ns	
Tf	Fall Time			4			
C _{iss}	Input Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		940			
Coss	Output Capacitance			131		pF	
C _{rss}	Reverse Transfer Capacitance			109			

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,5}	V _G =V _D =0V , Force Current			9	Α
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25°C			1	V
t _{rr}	Reverse Recovery Time	IF=8A , di/dt=100A/μs ,		8		nS
Qrr	Reverse Recovery Charge			2.9		nC

Note

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2.The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%
- 3. The EAS data shows Max. rating . The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS} =22A
- 4. The power dissipation is limited by 150°C junction temperature
- 5. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

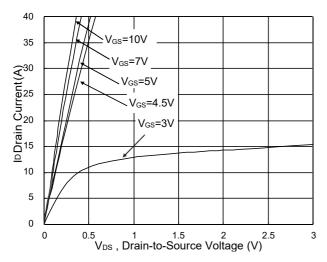


Fig.1 Typical Output Characteristics

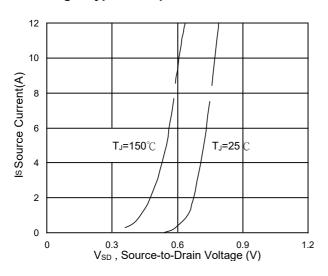


Fig.3 Source Drain Forward Characteristics

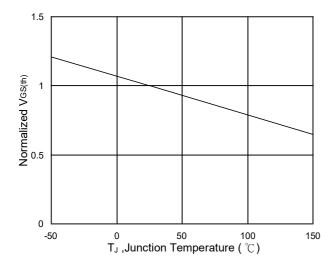


Fig.5 Normalized $V_{\text{GS(th)}}$ vs. T_J

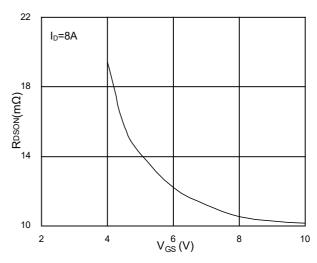


Fig.2 On-Resistance vs. G-S Voltage

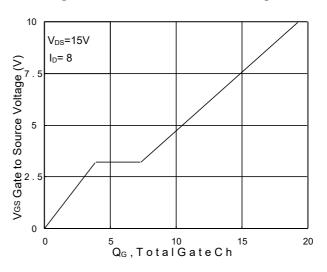


Fig.4 Gate-Charge Characteristics

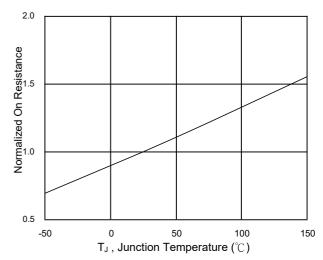
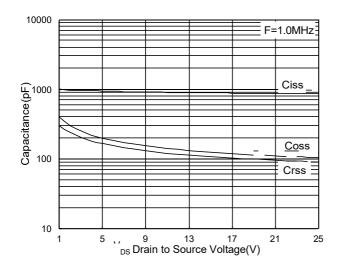


Fig.6 Normalized RDSON vs. TJ





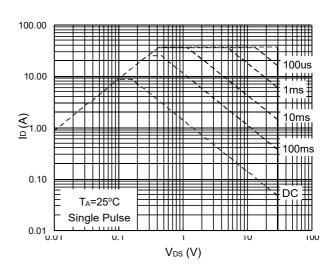


Fig.7 Capacitance

Fig.8 Safe Operating Area

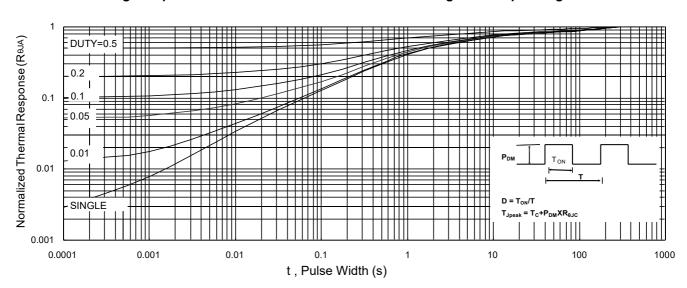
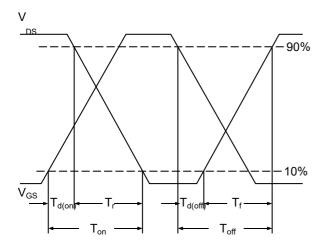
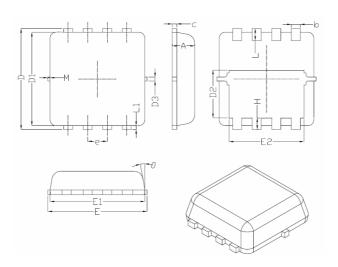


Fig.9 Normalized Maximum Transient Thermal Impedance



$$EAS = \frac{1}{L} L \times I_{AS}^2 \times \frac{DV_{DSS}}{L}$$

DFN3X3-8L Package Information



Ohl	Dimensions In Millimeters			
Symbol	Min.	Nom.	Max.	
A	0.70	0.75	0.80	
b	0.25	0.30	0.35	
С	0.10	0.15	0.25	
D	3.25	3.35	3.45	
D1	3.00	3.10	3.20	
D2	1.48	1.58	1.68	
D3	-	0.13	-	
E	3.20	3.30	3.40	
E1	3.00	3.15	3.20	
E2	2.39	2.49	2.59	
е	0.65BSC			
Н	0.30	0.39	0.50	
L	0.30	0.40	0.50	
L1	-	0.13	-	
M	*	*	0.15	
θ		10 [°]	12 [°]	

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